



Silicon N-Channel Power MOSFET



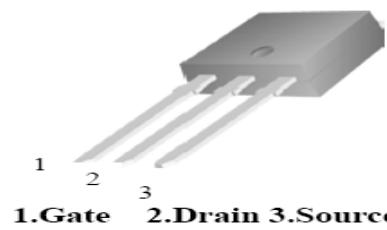
CS5J65 B3-G

General Description:

CS5J65 B3-G, the silicon N-channel Enhanced MOSFETs, is obtained by the super junction technology which reduces the conduction loss, improve switching performance and enhance the avalanche energy. The transistor can be used in various power switching circuit for system miniaturization and higher efficiency. The package type is TO-251, which accords with the RoHS standard.

V _{DSS}	650	V
I _D	5	A
P _D (T _C =25°C)	72	W
R _{DS(ON)Typ}	0.9	Ω

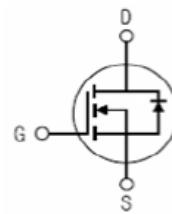
TO-251



Features:

- | Fast Switching
- | Low Gate Charge
- | Low Reverse transfer capacitances
- | 100% Single Pulse avalanche energy Test
- | Halogen Free

Inner Equivalent Principium Chart



Applications:

Power switch circuit of adaptor and charger.

Absolute (T_c= 25°C unless otherwise specified):

Symbol	Parameter	Rating	Units
V _{DSS}	Drain-to-Source Voltage(V _{GS} =0V)	650	V
I _D	Continuous Drain Current	5	A
I _{DM} ^{a1}	Pulsed Drain Current	15	A
V _{GSS}	Gate-to-Source Voltage	±30	V
E _{AS} ^{a2}	Single Pulse Avalanche Energy	50	mJ
dv/dt ^{a3}	Peak Diode Recovery dv/dt	5	V/ns
P _D	Power Dissipation(T=25°C)	72	W
T _J , T _{stg}	Operating and Storage Temperature Range	-55...+150	°C
T _L	Maximum Temperature for Soldering	300	°C

**Electrical Characteristics (Tc= 25°C unless otherwise specified):**

OFF Characteristics						
Symbol	Parameter	Test Conditions	Rating			Units
			Min.	Typ.	Max.	
V _{DSS}	Drain to Source Breakdown Voltage	V _{GS} =0V, I _D =250μA	650	--	--	V
Δ BV _{DSS} / Δ T _J	Bvdss Temperature Coefficient	I _D =250uA	--	0.65	--	V/°C
I _{DSS}	Drain to Source Leakage Current	V _{DS} = 650V, V _{GS} = 0V, T _a = 25°C	--	--	1	μA
		V _{DS} = 520V, V _{GS} = 0V, T _a = 125°C	--	--	10	
I _{GSS(F)}	Gate to Source Forward Leakage	V _{GS} =+30V V _{DS} = 0V,	--	--	100	nA
I _{GSS(R)}	Gate to Source Reverse Leakage	V _{GS} =-30V V _{DS} = 0V,	--	--	-100	nA

ON Characteristics						
Symbol	Parameter	Test Conditions	Rating			Units
			Min.	Typ.	Max.	
R _{DS(ON)}	Drain-to-Source On-Resistance	V _{GS} =10V,I _D =2.5A	--	0.9	1.2	Ω
V _{GS(TH)}	Gate Threshold Voltage	V _{DS} = V _{GS} , I _D = 250μA	2.0	--	4.0	V
Pulse width tp≤300μs, δ ≤2%						

Dynamic Characteristics						
Symbol	Parameter	Test Conditions	Rating			Units
			Min.	Typ.	Max.	
C _{iss}	Input Capacitance	V _{GS} = 0V V _{DS} = 25V f = 1.0MHz	--	313	--	pF
C _{oss}	Output Capacitance		--	301	--	
C _{rss}	Reverse Transfer Capacitance		--	10	--	

Resistive Switching Characteristics						
Symbol	Parameter	Test Conditions	Rating			Units
			Min.	Typ.	Max.	
t _{d(ON)}	Turn-on Delay Time	I _D =5A V _{DD} = 325V V _{GS} = 10V R _G =10Ω	--	12	--	ns
tr	Rise Time		--	23	--	
t _{d(OFF)}	Turn-Off Delay Time		--	35	--	
t _f	Fall Time		--	9	--	
Q _g	Total Gate Charge	I _D = 5A V _{DD} =520V V _{GS} = 10V	--	12	--	nC
Q _{gs}	Gate to Source Charge		--	2.2	--	
Q _{gd}	Gate to Drain ("Miller")Charge		--	6.2	--	



Source-Drain Diode Characteristics						
Symbol	Parameter	Test Conditions	Rating			Units
			Min.	Typ.	Max.	
I _S	Continuous Source Current (Body Diode)	T _C =25°C	--	--	5	A
I _{SM}	Maximum Pulsed Current (Body Diode)		--	--	15	A
V _{SD}	Diode Forward Voltage	I _F =5A, V _{GS} =0V	--	0.9	1.2	V
trr	Reverse Recovery Time	I _S = I _F , T _j = 25°C dI _F /dt=100A/us, V _{GS} =0V	--	272	--	ns
Qrr	Reverse Recovery Charge		--	1890	--	nC

Thermal Restistance

Symbol	Parameter	Max.	Units
R _{θJC}	Junction-to-Case	1.7	°C/W
R _{θJA}	Junction-to-Ambient	100	°C/W

^{a1}: Repetitive rating; pulse width limited by maximum junction temperature

^{a2}: L=20.0mH, R_g=25 Ω, V_{dd}=50V, Start T_j=25°C

^{a3}: I_{SD}=5A, di/dt ≤100A/us, V_{DD}≤BV_{DS}, Start T_j=25°C

Characteristics Curve:

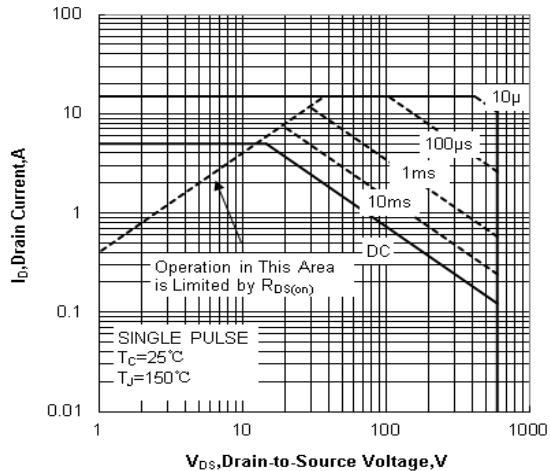


Figure.1 Maximum Forward Bias Safe Operating Area

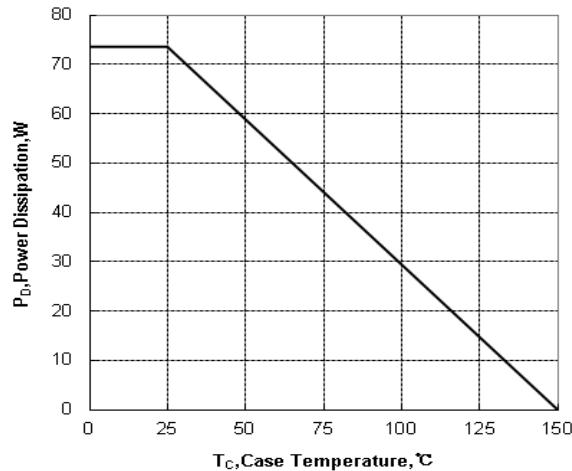


Figure.2 Maximum Power Dissipation vs Case Temperature

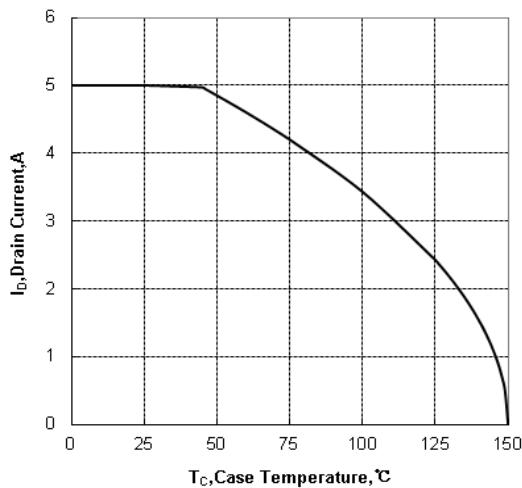


Figure.3 Maximum Continuous Drain Current vs Case Temperature

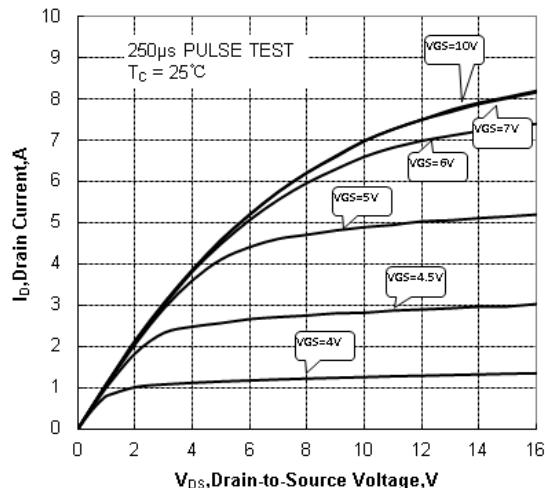


Figure.4 Typical Output Characteristics

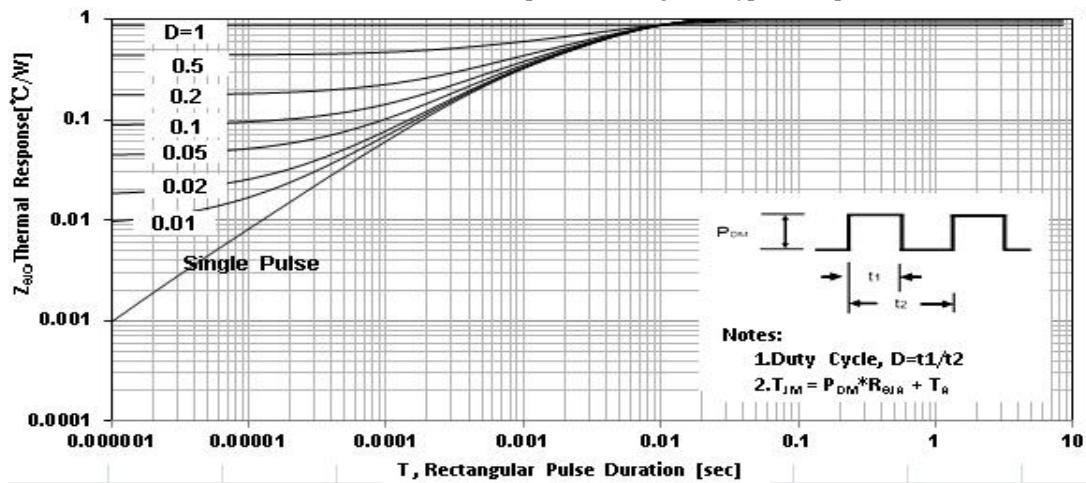


Figure.5 Maximum Effective Thermal Impedance , Junction to Case

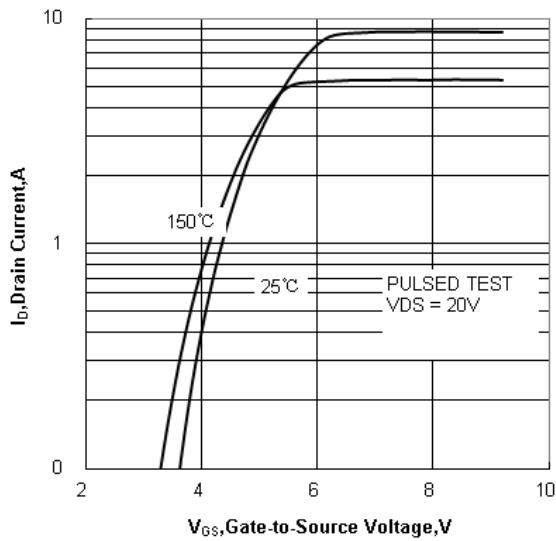


Figure.6 Typical Transfer Characteristics

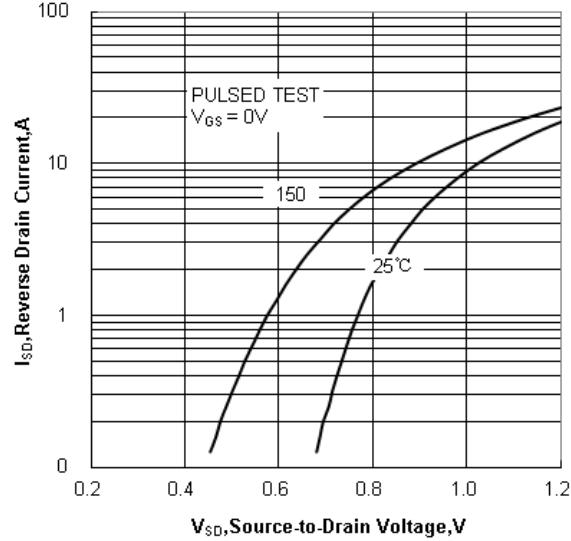


Figure.7 Typical Body Diode Transfer Characteristics

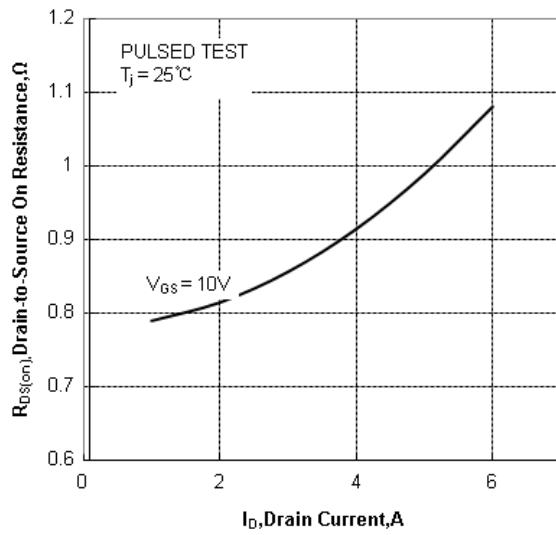


Figure.8 Typical Drain to Source ON Resistance vs Drain Current

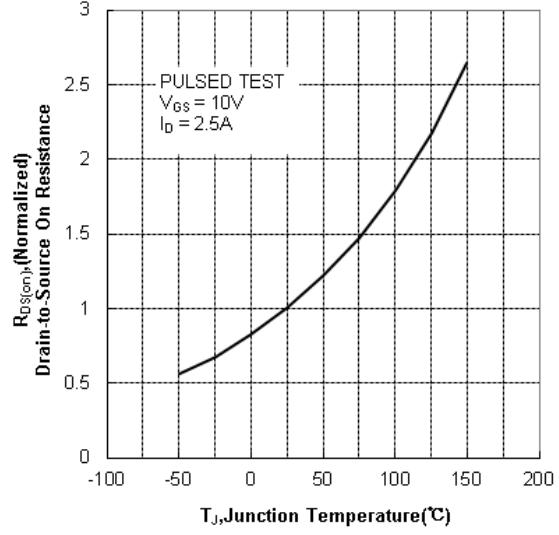


Figure.9 Typical Drian to Source on Resistance vs Junction Temperature

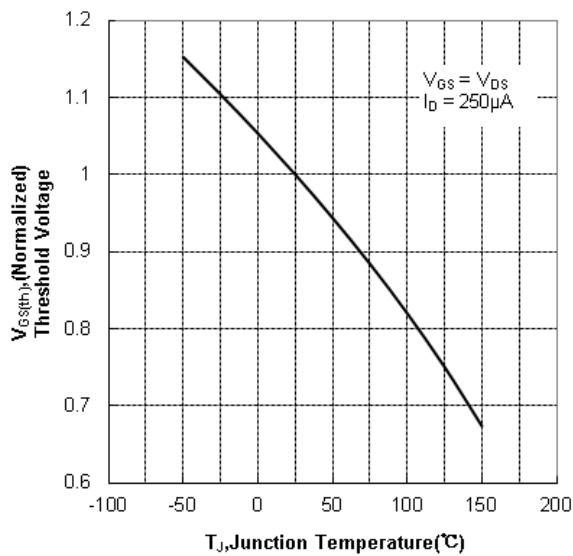


Figure.10 Typical Threshold Voltage vs Junction Temperature

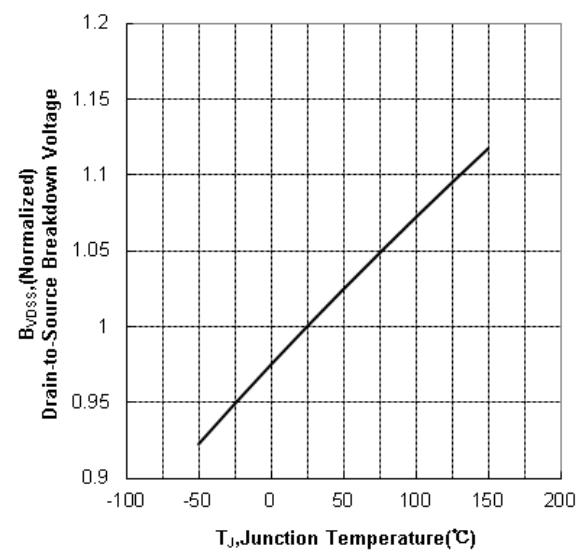


Figure 11 Typical Breakdown Voltage vs Junction Temperature

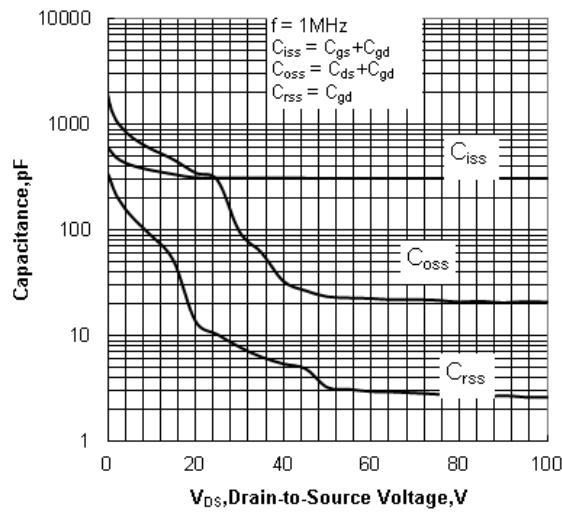


Figure.12 Typical Capacitance vs Drain to Source Voltage

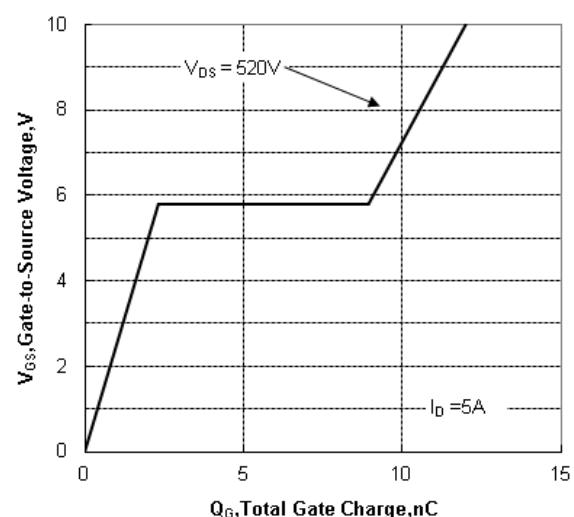


Figure.13 Typical Gate Charge vs Gate to Source Voltage

Test Circuit and Waveform



Figure 14. Gate Charge Test Circuit

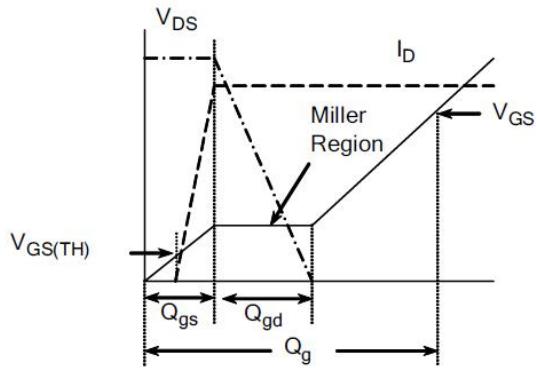


Figure 15. Gate Charge Waveforms

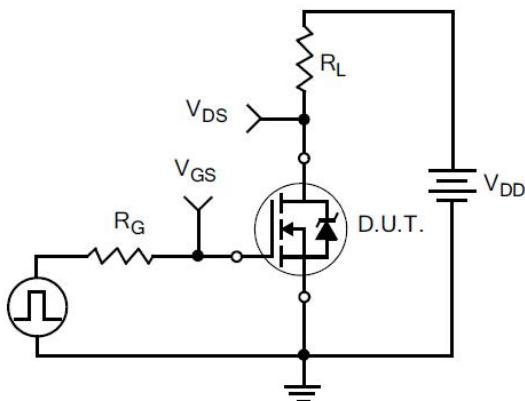


Figure 16. Resistive Switching Test Circuit

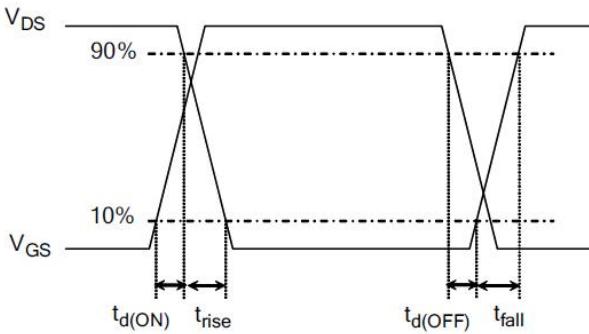


Figure 17. Resistive Switching Waveforms

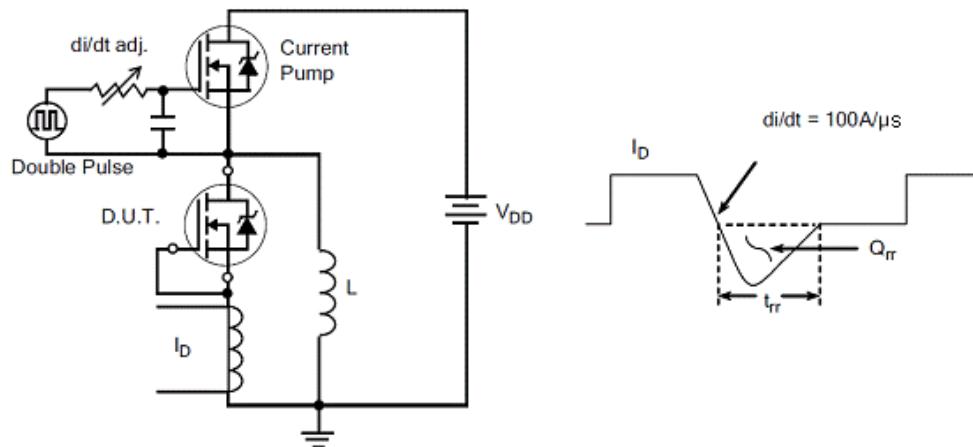


Figure 18. Diode Reverse Recovery Test Circuit

Figure 19. Diode Reverse Recovery Waveform

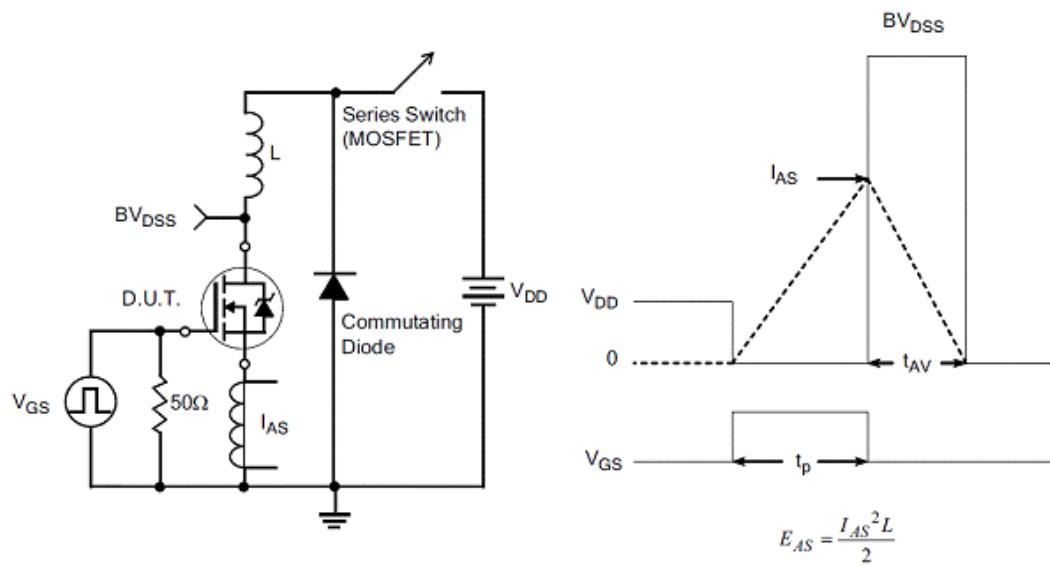
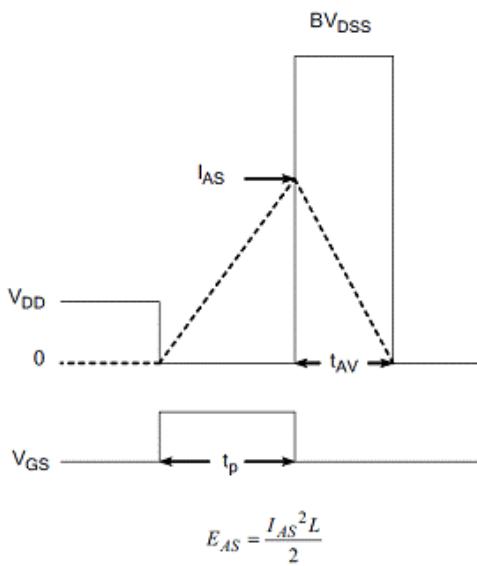


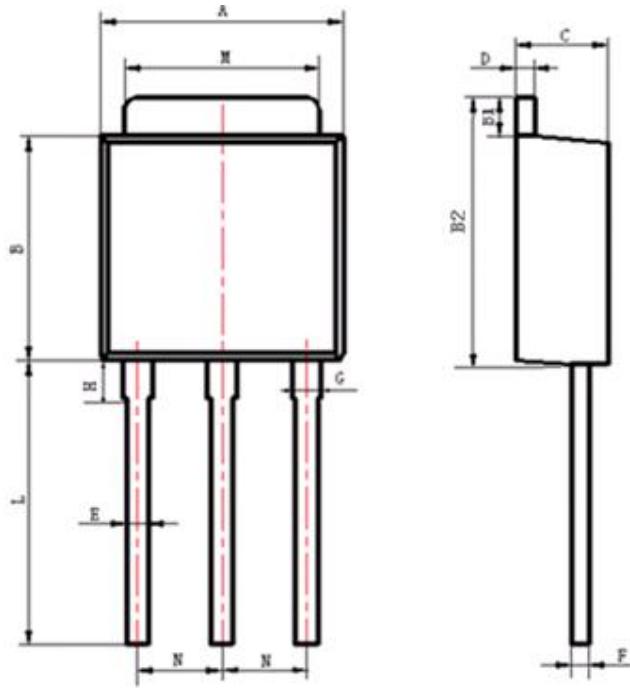
Figure 20. Unclamped Inductive Switching Test Circuit

Figure 21. Unclamped Inductive Switching Waveform





Package Information



Items	Values(mm)	
	MIN	MAX
A	6.30	6.90
B	5.70	6.30
B1	1.00	1.20
B2	6.80	7.40
C	2.10	2.50
D	0.30	0.60
E	0.50	0.70
F	0.30	0.60
G	0.70	1.00
H	1.60	2.40
L*	7.70	9.80
M	5.10	5.50
N	2.09	2.49

*:adjustable

TO-251 Package



The name and content of poisonous and harmful material in products

Warnings

1. Exceeding the maximum ratings of the device in performance may cause damage to the device, even the permanent failure, which may affect the dependability of the machine. It is suggested to be used under 80 percent of the maximum ratings of the device.
 2. When installing the heat sink, please pay attention to the torsional moment and the smoothness of the heatsink.
 3. VDMOSFET is the device which is sensitive to the static electricity, it is necessary to protect the device from being damaged by the static electricity when using it.
 4. This publication is made by Huajing Microelectronics and subject to regular change without notice.

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